



TEST REPORT

Applicant: SHENZHEN YUNJI INTELLIGENT TECHNOLOGY CO.,LTD
A2 2F BUILDING ENET NEW INDUSTRIAL PARK, DAFU

Address of Applicant: INDUSTRIALZONE, GUANLAN, LONGHUA SHENZHEN, 518XXX
China

Manufacturer/Factory: SHENZHEN YUNJI INTELLIGENT TECHNOLOGY CO.,LTD
A2 2F BUILDING ENET NEW INDUSTRIAL PARK, DAFU

Address of Manufacturer: INDUSTRIALZONE, GUANLAN, LONGHUA SHENZHEN, 518XXX
China

Product Name: Smart phone

Model No.: C26 Mini, C26,C26 S,C26 E,C26 Pro,C26 Plus,C26 Ultra,
C26 Max,C26 GT,C26 Go,C26 Lite

Trade Mark: OUKITE

FCC ID: 2ANMU-C26MINI

Applicable standards: 47 CRF Part 2, 90
ANSI C63.26:2015,ANSI/TIA-603-E-2016

Test Procedure:: KDB 971168 D01 Power Meas License Digital Systems v03r01

Date of Test: Sept. 03, 2026- Sept. 15, 2026

Date of report issued: Sept. 15, 2026

Remark:

The results shown in this test report refer only to the sample(s) tested , this test report cannot be reproduced, except in full without prior written permission of the company.

The report would be invalid without specific stamp of test institute and the signatures of compiler and approver.

Prepared By

Shenzhen ETR Standard Technology Co., Ltd.

Address: No.103, No.10, Phase I, Zone 3, Xinxing Industrial Park, Xinhe, Fuhai Street, Bao'an District, Shenzhen,
Guangdong, China

Compiled by:

Reviewed by:

Approved by:

Yunji Fan

Project Engineer

Smith Chen

Project Manager





Report Revision History		
Report No.	Description	Issue Date
ET-26094838E08	Original	Sept. 15, 2026

Table of Contents

1. TEST SUMMARY	4
1.1 Applicable Standards	4
1.2 Summary of Test Results	4
1.3 Test Facility	5
1.4 Measurement Uncertainty	5
2. GENERAL INFORMATION	6
2.1 Client Information	6
2.2 Product Description	6
2.3 Table for Filed Antenna	8
2.4 Test Environment Condition	8
2.5 Channel List	8
2.6 Test Configuration of Equipment Under Test	9
2.7 Measurement Instruments	10
3. TEST CONDITIONS AND RESULTS	11
3.1 Conducted Output Power	11
3.2 Occupied Bandwidth	13
3.3 Frequency Stability	14
3.4 Spurious Emissions at Antenna Terminals	17
3.5 Band Edge	19
3.6 Field Strength of Spurious Radiation Measurement	21
4. APPENDIX-PHOTOS OF TEST SETUP	26

1. TEST SUMMARY

1.1 Applicable Standards

Test procedures according to the technical standards:

FCC CFR 47 Part 2, Part 90

ANSI C63.26(2015)

KDB 971168 D01 v03r01: Power Meas License Digital Systems

FCC KDB 971168 D02 v02r02: Misc Rev Approv License Devices

FCC KDB 412172 D01 v01r01: Determining ERP and EIRP

1.2 Summary of Test Results

FCC Part Section(s)	Test Description	Test Condition	Test Result
90.542 90.635	Conducted Output Power	Conducted	Pass
2.1049	Occupied Bandwidth		Pass
2.1055 90.213 90.539	Frequency Stability		Pass
2.1051 90.543(e) 90.691(a)	Transmitter unwanted emissions (spurious)		Pass
2.1051 90.543(e) 90.691(a)	Transmitter unwanted emissions (band-edge)		Pass
2.1053 90.543(e) 90.691(a)	Transmitter Spurious Emissions	Radiated	Pass

Note:

All supported modulation types were evaluated, and the worst-case emission from modulation types was selected. Therefore, the worst-case results for Frequency Stability, Conducted Spurious Emission, and Radiated Spurious Emission were presented in the test report.

1.3 Test Facility

Test laboratory:	Shenzhen ETR Standard Technology Co., Ltd.
CNAS Registration Number:	L11864
A2LA Certificate Number:	6640.01
FCC Designation Number:	CN1326
FCC Test Firm Registration:	183064
IC Company Number:	28440
IC CAB identifier:	CN0132
Laboratory location:	No.103, No.10, Phase I, Zone 3, Xinxing Industrial Park, Xinhe, Fuhai Street, Bao'an District, Shenzhen, Guangdong, China

1.4 Measurement Uncertainty

Test Item	Uncertainty Criterion	Measurement Uncertainty	Notes
Occupied Channel Bandwidth	±5%	±0.72%	(1)
RF output power, conducted	±1.5dB	±0.67 dB	(1)
Power Spectral Density, conducted	±3dB	±0.51 dB	(1)
Unwanted Emissions, conducted	±3dB	±0.64 dB	(1)
AC Power Line Conducted Emission	±6dB	± 3.38 dB	(1)
Radiated emissions Below 1GHz	±6dB	±4.26 dB	(1)
Radiated emissions Above 1GHz	±6dB	±4.88 dB	(1)

Note (1): The measurement uncertainty is for coverage factor of k=2 and a level of confidence of 95%.

2. GENERAL INFORMATION

2.1 Client Information

Applicant:	SHENZHEN YUNJI INTELLIGENT TECHNOLOGY CO.,LTD
Address of Applicant:	A2 2F BUILDING ENET NEW INDUSTRIAL PARK, DAFU INDUSTRIALZONE, GUANLAN, LONGHUA SHENZHEN, 518XXX China
Manufacturer:	SHENZHEN YUNJI INTELLIGENT TECHNOLOGY CO.,LTD
Address of Manufacturer	A2 2F BUILDING ENET NEW INDUSTRIAL PARK, DAFU INDUSTRIALZONE, GUANLAN, LONGHUA SHENZHEN, 518XXX China

2.2 Product Description

2.2.1 Main unit information

Product Name	Smart phone
Brand Name	OUKITE
Model Name	C26 Mini
Series Model(s)	C26,C26 S,C26 E,C26 Pro,C26 Plus,C26 Ultra,C26 Max, C26 GT,C26 Go,C26 Lite
Model Difference	Only different in model name
Power Rating	Input: DC 5V 2A
Hardware version	N/A
Software version	N/A

2.2.2 Accessory unit information

Adapter	Model: S215 Brand: N/A Rated Voltage: 3.85V Charge Limit Voltage: 4.4V Capacity: 2300mAh Manufacturer: Zhongshan Jiuliyuan New Energy Technology Co., Ltd. Address: 2-3F, Building 4; 2-4F, Building 5, No. 20, Beichen Road, Cuiheng New Area, Nanlang Street, Zhongshan City, Guangdong Province, China
Battery	Model: HJ-0502000N2-US Brand: N/A Input: 100-240V~50/60Hz 0.3A Output: 5.0V=2.0A Manufacturer: SHENZHEN HUAJIN ELECTRONICSCO LTD Address: BLK E 518000/BLK E XINZHONGQIAO INDUSTRIAL PARK BAOLONG SIX RD BAOLONG INDUSTRIAL CITY LONGGANGDISTRICT,SHENZHEN,GUANGDONG,51800 OCHINA



2.2.3 Radio Specification information

Tx Frequency:	Band26:814~824MHz
Rx Frequency:	Band26:859~869MHz
Modulation Characteristics:	LTE: QPSK /16QAM
SIM Card:	SIM 1 and SIM 2 is a chipset unit and tested as single chipset, SIM 1 is used to tested

2.3 Table for Filed Antenna

Ant	Technology	Frequency Range (MHz)	Gain (dBi)	Antenna Type
1	Band26(814-824)	814~824	-0.89	FPC

Note: All antenna information (Antenna type and Peak Gain) is provided by the manufacturer.

2.4 Test Environment Condition

Ambient Temperature	15 ~ 35° C
Relative Humidity	20% ~ 75%RH
Air Pressure	95-105 kPa

2.5 Channel List

Band26 (Part 90) 814-824	Bandwidth (MHz)	Frequency (MHz)	Channel
L	1.4M	814.7	26697
	3M	815.5	26705
	5M	816.5	26715
M	1.4/3/5/10M	819	26740
H	1.4M	823.3	26783
	3M	822.5	26775
	5M	821.5	26765

2.6 Test Configuration of Equipment Under Test

Antenna port conducted and radiated test items were performed according to KDB 971168 D01 and ANSI C63.26 2015 Power Meas. License Digital Systems with maximum output power.

Radiated measurements were performed with rotating EUT in different three orthogonal test planes to find the maximum emission.

Radiated emissions were investigated as following frequency range:

1. 30 MHz to 10th harmonic for All frequency bands.

All modes and data rates and positions were investigated.

Test modes are chosen to be reported as the worst-case configuration below:

LTE					
Test Items	Bandwidth	Modulation	RB #		
			1	Half	Full
Conducted Spurious Emission	Note1	QPSK	√	--	--
Radiated Spurious Emission					

Note:

1: The radiation interference test covered all the bandwidth of the LTE frequency band. The bandwidth supported by each frequency band can be viewed in the 2.5 channel list.

2: The mark "--" means that this bandwidth is not test.

2.7 Measurement Instruments

Item	Equipment name	Manufacturer	Model	Serial No.	Calibration date	Due date
1	EMI Test Receiver	Rohde&schwarz	ESCI7	100605	2026.3.05	2027.3.04
2	EMI Test Receiver	Rohde&schwarz	ESCI3	102696	2026.3.05	2027.3.04
3	Loop Antenna	schwarabeck	FMZB 1519 B	FMZB 1519 B	2026.3.08	2028.3.07
4	Broadband antenna	schwarabeck	VULB9168	1064	2026.3.11	2028.3.10
5	Horn antenna	schwarabeck	BBHA9120D	9120D-1145	2026.3.08	2028.3.07
6	amplifier	EMtrace	RP01A	50117	2026.3.05	2027.3.04
7	Artificial power network	schwarabeck	NSLK8127	8127483	2026.3.05	2027.3.04
8	Artificial power network	ETS	3186/2NM	1132	2026.3.05	2027.3.04
9	10dB attenuator	HUBER+SUHNER	10dB	/	2026.3.05	2027.3.04
10	amplifier	Space-Dtronics	EWLAN0118G-P40	19113001	2026.3.05	2027.3.04
11	Filter	Xingbo	XBLBQ-GTA19	210410-3-1	2026.3.05	2027.3.04
12	Filter	Xin bo	XBLBQ-GTA29	210410-3-2	2026.3.05	2027.3.04
14	Automated filter bank	Tonscend	JS0806-F	CTA-404	2026.3.05	2027.3.04
15	Spectrum analyzer	KEYSIGHT	N9020A	MY55370280	2026.3.05	2027.3.04
16	Power detector box	MWRFTest	MW100-PSB	MW201020JYT	2026.3.05	2027.3.04
17	Amplifier	SKET	LNPA_1840-50	SK2019040302	2026.3.05	2027.3.04
18	Horn antenna	schwarabeck	BBHA 9170	946	2026.3.08	2028.3.07
19	Vector Signal generator	Agilent	N5182A	MY49060455	2026.3.05	2027.3.04
20	Power detector	MWRFTest	MW100-PSB	MW201020JYT	2026.3.05	2027.3.04
21	Comprehensive test instrument	Rohde&schwarz	cmw500	149155	2026.3.05	2027.3.04
22	Spectrum analyzer	Rohde&schwarz	FSV40	1166.1660K43	2026.3.05	2027.3.04

Note: the calibration interval of the above test instruments is 12 or 24 months and the calibrations are traceable to international system unit (SI).

Software Name	Manufacturer	Model	Version
LTE test software	WCS	WCS-LTE	Ver:25.09.1601
EMI Test soft	Farad	EZ-EMC	Ver.EMC-CON 3A1.1
EMI Test soft	Farad	EZ-EMC	Ver.FA-03A2 RE

3. TEST CONDITIONS AND RESULTS

3.1 Conducted Output Power

3.1.1 Test Limit

For Band26:

The maximum output power of the transmitter for mobile stations is 100 watts (20dBw).

3.1.2 Test Procedures

ANSI C63.26-2015 - Section 5.2.4.2

3.1.3 Test Setting

CONDUCTED OUTPUT POWER:

Average power measurements were performed only when the EUT was transmitting at its maximum power control level using a broadband power meter with a pulse sensor. The power meter implemented triggering and gating capabilities which were set up such that power measurements were recorded only during the ON time of the transmitter.

TRANSMITTER RADIATED POWER (EIRP/ERP)

Determining ERP and/or EIRP from conducted RF output power measurements according to ANSI C63.26 2015 Section 5.2.5.5.

In many cases, RF output power limits are specified in terms of the ERP or the EIRP. Typically, ERP is specified when the operating frequency is less than or equal to 1 GHz and EIRP is specified when the operating frequency is greater than 1 GHz. Both are defined as the product of the power supplied to the antenna and its gain (relative to a dipole antenna in the case of ERP, and relative to an isotropic antenna in the case of EIRP); however, when working in decibels (i.e., logarithmic scale), the ERP and EIRP represent the sum of the transmit antenna gain (in dBd or dBi, respectively) and the conducted RF output power (expressed in dB relative to watts or milliwatts).

The relevant equation for determining the maximum ERP or EIRP from the measured RF output power is given in Equation (1) as follows:

(1) $ERP \text{ or } EIRP = P_{Meas} + GT$

$EIRP = \text{Conducted power} + \text{antenna gain}$

$ERP = EIRP - 2.15$

Where:

ERP or EIRP effective radiated power or equivalent isotropically radiated power, respectively (expressed in the same units as P_{Meas} , e.g., dBm or dBW)

P_{Meas} measured transmitter output power or PSD, in dBm or dBW

GT gain of the transmitting antenna, in dBd (ERP) or dBi (EIRP)

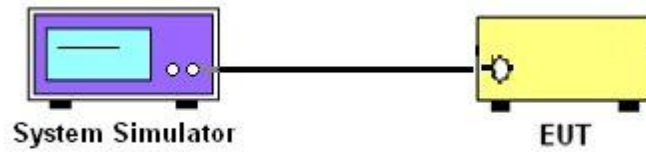
For devices utilizing multiple antennas, see 6.4 for guidance with respect to determining the effective array transmit antenna gain term to be used in the above equation.

The following equations demonstrate the mathematical relationship between ERP and EIRP:

a) $ERP = EIRP - 2.15$, where ERP and EIRP are expressed in consistent units.

b) $EIRP = ERP + 2.15$, where ERP and EIRP are expressed in consistent units.

3.1.4 Test Setup



3.1.5 Test Result

Note: The test data please reference to attachment "Appendix RF Test Data For LTE Part 90".

3.2 Occupied Bandwidth

3.2.1 Test Limit

The occupied bandwidth, that is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers radiated are each equal to 0.5 percent of the total mean power radiated by a given emission shall be measured.

All modes of operation were investigated and the worst-case configuration results are reported in this section.

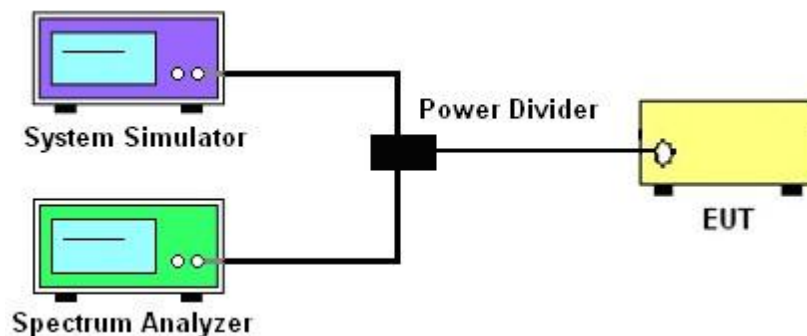
3.2.2 Test Procedure

ANSI C63.26-2015 - Section 5.4.4

3.2.3 Test Setting

1. Set center frequency to the nominal EUT channel center frequency
2. RBW = The nominal RBW shall be in the range of 1% to 5% of the anticipated OBW
3. $VBW \geq 3 \times RBW$
4. Detector = Peak
5. Trace mode = max hold
6. Sweep = auto couple
7. Allow the trace to stabilize
8. Use the 99% power bandwidth function of the instrument and report the measured bandwidth.

3.2.4 Test Setup



3.2.5 Test Result

Note: The test data please reference to attachment “Appendix RF Test Data For LTE Part 90”.

3.3 Frequency Stability

3.3.1 Test Limit

The frequency stability shall be measured by variation of ambient temperature and variation of primary supply voltage to ensure that the fundamental emission stays within the authorized frequency block.

The frequency stability of the transmitter shall be maintained within $\pm 0.00025\%$ ($\pm 2.5\text{ppm}$) of the center frequency.

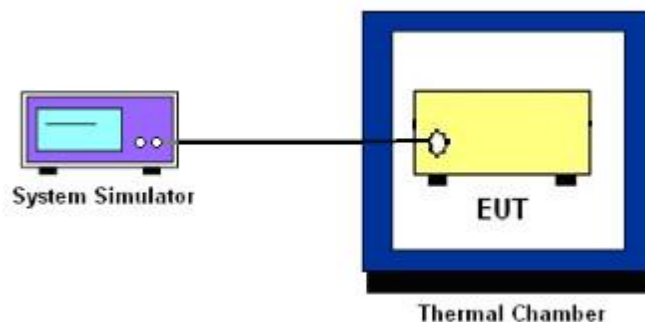
3.3.2 Test Procedure

ANSI C63.26-2015 - Section 5.6

3.3.3 Test Setting

1. A reference point shall be established at the applicable unwanted emissions limit using a RBW equal to the RBW required by the unwanted emissions specification of the applicable regulatory standard. These reference points measured using the lowest and highest channel of operation shall be identified as f_L and f_H respectively.
2. Use the frequency error function of the instrument and record the frequency error.
3. Change the temperature of equipment and repeat Steps 2.
4. Change the Voltage of equipment and repeat Steps 2.
5. The frequency error offset determined in the above methods shall be added or subtracted from the values of f_L and f_H and the resulting frequencies must remain within the band

3.3.4 Test Setup



3.3.5 Test Result

LTE Band 26 (QPSK) / 819MHz / BW5M					
Temperature (°C)	Voltage (Volt)	Freq. Dev. (Hz)	Freq. Dev. (ppm)	Limit	Result
50	Normal Voltage	30.12	0.037	2.5ppm	PASS
40		33.35	0.041		
30		14.33	0.017		
20		34.51	0.042		
10		20.05	0.024		
0		19.61	0.024		
-10		34.22	0.042		
-20		32.88	0.040		
-30		13.11	0.016		
20	Maximum Voltage	23.75	0.029	2.5ppm	PASS
20	BEP	20.82	0.025		

LTE Band 26 (16QAM) / 819MHz / BW5M					
Temperature (°C)	Voltage (Volt)	Freq. Dev. (Hz)	Freq. Dev. (ppm)	Limit	Result
50	Normal Voltage	19.74	0.024	2.5ppm	PASS
40		20.09	0.025		
30		20.51	0.025		
20		20.40	0.025		
10		24.90	0.030		
0		30.86	0.038		
-10		35.78	0.044		
-20		16.42	0.020		
-30		22.08	0.027		
20	Maximum Voltage	11.75	0.014	2.5ppm	PASS
20	BEP	22.11	0.027		

LTE Band 26 (QPSK) / 819MHz / BW10M					
Temperature (°C)	Voltage (Volt)	Freq. Dev. (Hz)	Freq. Dev. (ppm)	Limit	Result
50	Normal Voltage	26.60	0.032	2.5ppm	PASS
40		18.26	0.022		
30		20.82	0.025		
20		25.50	0.031		
10		34.51	0.042		
0		36.47	0.045		
-10		25.61	0.031		
-20		11.80	0.014		
-30		26.36	0.032		
20	Maximum Voltage	12.03	0.015		
20	BEP	23.78	0.029		

LTE Band 26 (16QAM) / 819MHz / BW10M					
Temperature (°C)	Voltage (Volt)	Freq. Dev. (Hz)	Freq. Dev. (ppm)	Limit	Result
50	Normal Voltage	27.29	0.033	2.5ppm	PASS
40		22.21	0.027		
30		31.93	0.039		
20		34.51	0.042		
10		16.26	0.020		
0		19.03	0.023		
-10		28.15	0.034		
-20		28.47	0.035		
-30		35.59	0.043		
20	Maximum Voltage	14.17	0.017		
20	BEP	12.03	0.015		

3.4 Spurious Emissions at Antenna Terminals

3.4.1 Test Limit

For Band26:

For any frequency removed from the EA licensee's frequency block greater than 37.5 kHz, the power of any emission shall be attenuated below the transmitter power (P) in watts by at least $43 + 10\log_{10}(P)$ decibels or 80 decibels, whichever is the lesser attenuation, where f is the frequency removed from the center of the outer channel in the block in kilohertz and where f is greater than 37.5 kHz.

It is measured by means of a calibrated spectrum analyzer and scanned from 30 MHz up to a frequency including its 10th harmonic.

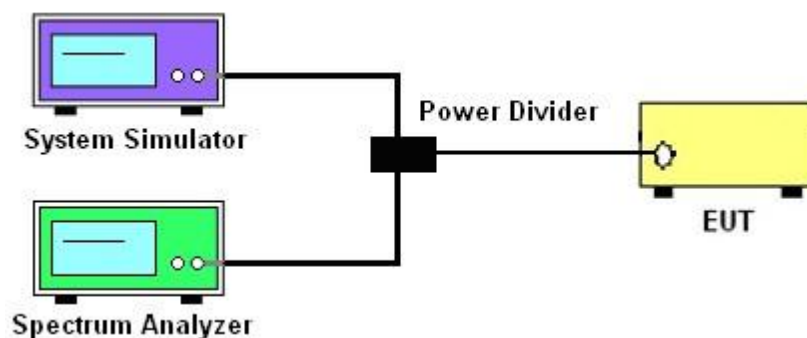
3.4.2 Test Procedure

ANSI C63.26-2015-Section 5.7.

3.4.3 Test Setting

1. Set the analyzer frequency to low, Mid or high channel.
2. RBW = specified resolution bandwidth
3. VBW $\geq 3 \times$ RBW
4. Sweep time = auto
5. Detector = power averaging (rms)
6. If the EUT can be configured to transmit continuously, then set the trigger to free run
7. If the EUT cannot be configured to transmit continuously, then use a sweep trigger with the level set to enable triggering only on full power bursts and configure the EUT to transmit at full power for the entire duration of each sweep. Verify that the sweep time is less than or equal to the transmission burst duration. Time gating can also be used under similar constraints
8. Use the peak marker function to determine the maximum amplitude level.

3.4.4 Test Setup





3.4.5 Test Result

Note: The test data please reference to attachment "Appendix RF Test Data For LTE Part 90".

3.5 Band Edge

3.5.1 Test Limit

For Band26:

Out-of-band emission requirement shall apply only to the “outer” channels included in an EA license and to spectrum adjacent to interior channels used by incumbent licensees. The emission limits are as follows:

- (1) For any frequency removed from the EA licensee's frequency block by up to and including 37.5 kHz, the power of any emission shall be attenuated below the transmitter power (P) in watts by at least $116 \log_{10}(f/6.1)$ decibels or $50 + 10 \log_{10}(P)$ decibels or 80 decibels, whichever is the lesser attenuation, where f is the frequency removed from the center of the outer channel in the block in kilohertz and where f is greater than 12.5 kHz.
- (2) For any frequency removed from the EA licensee's frequency block greater than 37.5 kHz, the power of any emission shall be attenuated below the transmitter power (P) in watts by at least $43 + 10 \log_{10}(P)$ decibels or 80 decibels, whichever is the lesser attenuation, where f is the frequency removed from the center of the outer channel in the block in kilohertz and where f is greater than 37.5 kHz.

In all cases, the frequency range for the band-edge or emission mask measurements shall be selected such that compliance with the applicable emission limit(s) can be demonstrated at the block/band/channel-edge frequencies and beyond as specified in the relevant regulations. Spectrum plots shall be included in the report for demonstrating compliance with all of the applicable emissions limits.

3.5.2 Test Procedure

ANSI C63.26-2015-Section 5.7

3.5.3 Test Setting

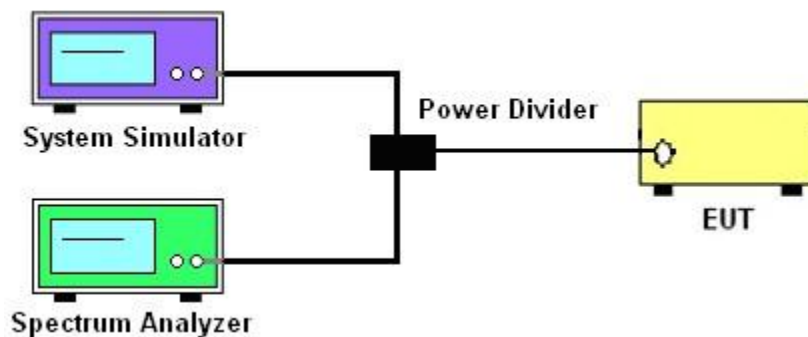
1. Set the analyzer frequency to Low or High channel
2. RBW = specified resolution bandwidth, for improvement of the accuracy in the measurement of the average power of a noise-like emission, a RBW narrower than the specified reference bandwidth can be used (generally limited to no less than 1% of the frequency block group, provided that a subsequent integration is performed over the full required measurement bandwidth. This integration should be performed using the spectrum analyzer's band power functions.
3. $VBW \geq 3 \times RBW$
4. Sweep time = auto
5. Detector = power averaging (rms)
6. If the EUT can be configured to transmit continuously, then set the trigger to free run

7. If the EUT cannot be configured to transmit continuously, then use a sweep trigger with the level set to enable triggering only on full power bursts and configure the EUT to transmit at full power for the entire duration of each sweep. Verify that the sweep time is less than or equal to the transmission burst duration.

Time gating can also be used under similar constraints

8. Compute the power by integrating the spectrum across the specified resolution bandwidth using the instrument's band or channel power measurement function, with the band/channel limits set equal to the specified resolution bandwidth, when using a measurement bandwidth smaller than the specified bandwidth. Otherwise, Use the peak marker function to determine the maximum amplitude level.

3.5.4 Test Setup



3.5.5 Test Result

Note: The test data please reference to attachment "Appendix RF Test Data For LTE".

3.6 Field Strength of Spurious Radiation Measurement

3.6.1 Test Limit

For Band26:

For any frequency removed from the EA licensee's frequency block greater than 37.5 kHz, the power of any emission shall be attenuated below the transmitter power (P) in watts by at least $43 + 10\log_{10}(P)$ decibels or 80 decibels, whichever is the lesser attenuation, where f is the frequency removed from the center of the outer channel in the block in kilohertz and where f is greater than 37.5 kHz.

Radiated spurious emissions measurements are performed using the substitution method described in ANSI C63.26-2015 with the EUT transmitting into an integral antenna. Measurements on signals operating below 1GHz are performed using horizontally and vertically polarized tuned dipole antennas. Measurements on signals operating above 1GHz are performed using vertically and horizontally polarized horn antennas. All measurements are performed as peak measurements while the EUT is operating at maximum power and at the appropriate frequencies.

It is measured by means of a calibrated spectrum analyzer and scanned from 30 MHz up to a frequency including its 10th harmonic.

For specific limits, please refer to the corresponding standards in the Summary.

3.6.2 Test Procedure

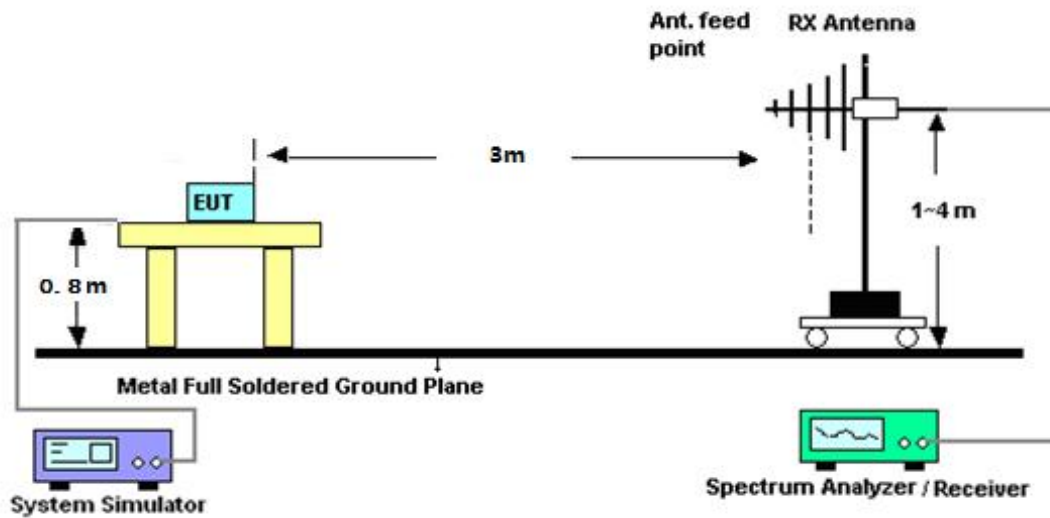
ANSI C63.26-2015 - Section 5.2.7 & 5.5

3.6.3 Test Setting

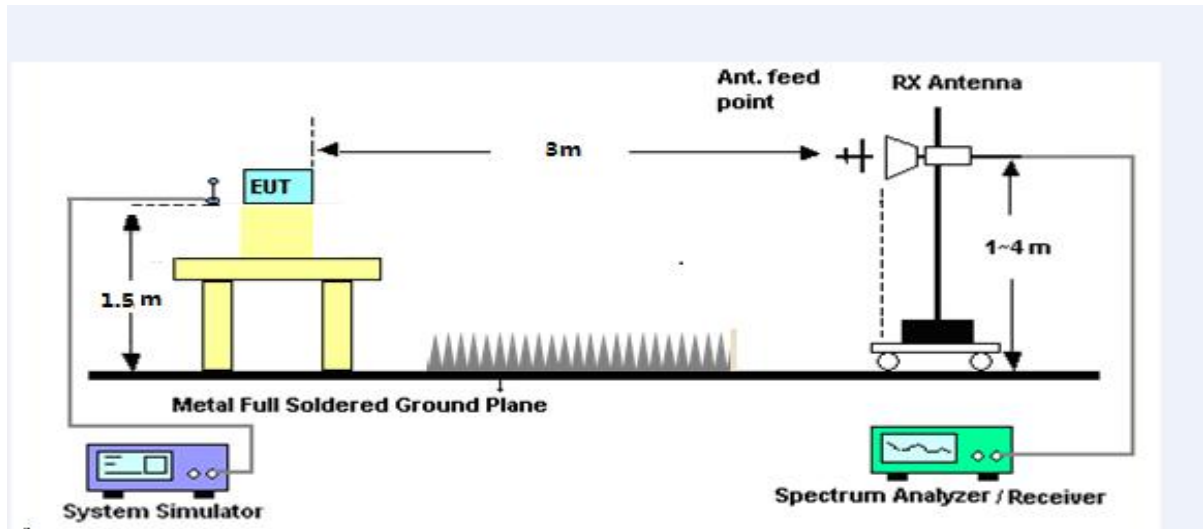
1. RBW = 120kHz or 1MHz
2. VBW $\geq 3 \times$ RBW
3. Sweep time $\geq 10 \times$ (number of points in sweep) $\times$ (transmission symbol period)
4. Detector = CISPR quasi-peak/average detector (Below 1 GHz, compliance with the limits shall be demonstrated using a CISPR quasi-peak detector and the related measurement bandwidth. Above 1 GHz, compliance with the limits shall be demonstrated using a linear average detector with a minimum resolution bandwidth of 1 MHz.)
5. The trace was allowed to stabilize

3.6.4 Test Setup

For radiated test from 30MHz to 1GHz



For radiated test from above 1GHz



3.6.5 Test Result

Note:

- (1) Spurious emissions which are attenuated by more than 20dB below the permissible value for frequency below 1000MHz.
- (2) Above 3.5GHz amplitude of spurious emissions which are attenuated by more than 20dB below the permissible value
- (3) For the radiated emission tests, each axis (X, Y, Z) was also verified. The test results shown in the following sections represent the worst-case emissions.

LTE Band 26 / 1.4MHz / QPSK / RB Size 1 Offset 0/ The Worst Test Results for Lowest							
Frequency(MHz)	S G.Lev (dBm)	Ant(dBi)	Loss	PMea (dBm)	Limit (dBm)	Margin (dBm)	Polarity
1629.14	-33.93	9.56	9.72	-34.09	-13.00	-21.09	H
2444.60	-35.45	10.50	10.86	-35.81	-13.00	-22.81	H
3258.50	-32.94	12.78	11.57	-31.73	-13.00	-18.73	H
1629.14	-35.93	9.56	9.72	-36.09	-13.00	-23.09	V
2444.60	-34.67	10.50	10.86	-35.03	-13.00	-22.03	V
3258.50	-32.83	12.78	11.57	-31.62	-13.00	-18.62	V
LTE Band 26 / 1.4MHz / QPSK / RB Size 1 Offset 0/ The Worst Test Results for Middle							
Frequency(MHz)	S G.Lev (dBm)	Ant(dBi)	Loss	PMea (dBm)	Limit (dBm)	Margin (dBm)	Polarity
1638.16	-34.46	9.56	9.72	-34.62	-13.00	-21.62	H
2457.07	-34.46	10.50	10.86	-34.82	-13.00	-21.82	H
3276.25	-32.95	12.78	11.57	-31.74	-13.00	-18.74	H
1638.16	-34.95	9.56	9.72	-35.11	-13.00	-22.11	V
2457.07	-33.80	10.50	10.86	-34.16	-13.00	-21.16	V
3276.25	-32.66	12.78	11.57	-31.45	-13.00	-18.45	V
LTE Band 26 / 1.4MHz / QPSK / RB Size 1 Offset 0/ The Worst Test Results for Highest							
Frequency(MHz)	S G.Lev (dBm)	Ant(dBi)	Loss	PMea (dBm)	Limit (dBm)	Margin (dBm)	Polarity
1646.71	-33.77	9.56	9.72	-33.93	-13.00	-20.93	H
2469.85	-34.82	10.50	10.86	-35.18	-13.00	-22.18	H
3293.17	-32.43	12.78	11.57	-31.22	-13.00	-18.22	H
1646.71	-34.75	9.56	9.72	-34.91	-13.00	-21.91	V
2469.85	-34.58	10.50	10.86	-34.94	-13.00	-21.94	V
3293.17	-32.03	12.78	11.57	-30.82	-13.00	-17.82	V

LTE Band 26 / 3MHz / QPSK / RB Size 1 Offset 0/ The Worst Test Results for Lowest							
Frequency(MHz)	S G.Lev (dBm)	Ant(dBi)	Loss	PMea (dBm)	Limit (dBm)	Margin (dBm)	Polarity
1631.49	-34.41	9.56	9.72	-34.57	-13.00	-21.57	H
2446.48	-34.21	10.50	10.86	-34.57	-13.00	-21.57	H
3261.85	-33.03	12.78	11.57	-31.82	-13.00	-18.82	H
1631.49	-35.36	9.56	9.72	-35.52	-13.00	-22.52	V
2446.48	-34.40	10.50	10.86	-34.76	-13.00	-21.76	V
3261.85	-33.00	12.78	11.57	-31.79	-13.00	-18.79	V
LTE Band 26 / 3MHz / QPSK / RB Size 1 Offset 0/ The Worst Test Results for Middle							
Frequency(MHz)	S G.Lev (dBm)	Ant(dBi)	Loss	PMea (dBm)	Limit (dBm)	Margin (dBm)	Polarity
1638.10	-33.76	9.56	9.72	-33.92	-13.00	-20.92	H
2457.15	-34.01	10.50	10.86	-34.37	-13.00	-21.37	H
3276.01	-33.05	12.78	11.57	-31.84	-13.00	-18.84	H
1638.10	-34.63	9.56	9.72	-34.79	-13.00	-21.79	V
2457.15	-34.61	10.50	10.86	-34.97	-13.00	-21.97	V
3276.01	-32.27	12.78	11.57	-31.06	-13.00	-18.06	V
LTE Band 26 / 3MHz / QPSK / RB Size 1 Offset 0/ The Worst Test Results for Highest							
Frequency(MHz)	S G.Lev (dBm)	Ant(dBi)	Loss	PMea (dBm)	Limit (dBm)	Margin (dBm)	Polarity
1644.90	-34.40	9.56	9.72	-34.56	-13.00	-21.56	H
2467.48	-34.38	10.50	10.86	-34.74	-13.00	-21.74	H
3290.27	-32.36	12.78	11.57	-31.15	-13.00	-18.15	H
1644.90	-35.08	9.56	9.72	-35.24	-13.00	-22.24	V
2467.48	-34.57	10.50	10.86	-34.93	-13.00	-21.93	V
3290.27	-32.58	12.78	11.57	-31.37	-13.00	-18.37	V

LTE Band 26 / 5MHz / QPSK / RB Size 1 Offset 0/ The Worst Test Results for Lowest							
Frequency(MHz)	S G.Lev (dBm)	Ant(dBi)	Loss	PMea (dBm)	Limit (dBm)	Margin (dBm)	Polarity
1632.69	-34.46	9.56	9.72	-34.62	-13.00	-21.62	H
2448.88	-34.09	10.50	10.86	-34.45	-13.00	-21.45	H
3266.07	-33.62	12.78	11.57	-32.41	-13.00	-19.41	H
1632.69	-34.92	9.56	9.72	-35.08	-13.00	-22.08	V
2448.88	-34.62	10.50	10.86	-34.98	-13.00	-21.98	V
3266.07	-32.18	12.78	11.57	-30.97	-13.00	-17.97	V
LTE Band 26 / 5MHz / QPSK / RB Size 1 Offset 0/ The Worst Test Results for Middle							
Frequency(MHz)	S G.Lev (dBm)	Ant(dBi)	Loss	PMea (dBm)	Limit (dBm)	Margin (dBm)	Polarity
1643.20	-34.80	9.56	9.72	-34.96	-13.00	-21.96	H
2464.28	-35.17	10.50	10.86	-35.53	-13.00	-22.53	H
3286.11	-32.26	12.78	11.57	-31.05	-13.00	-18.05	H
1643.20	-35.67	9.56	9.72	-35.83	-13.00	-22.83	V
2464.28	-34.33	10.50	10.86	-34.69	-13.00	-21.69	V
3286.11	-33.09	12.78	11.57	-31.88	-13.00	-18.88	V
LTE Band 26 / 5MHz / QPSK / RB Size 1 Offset 0/ The Worst Test Results for Highest							
Frequency(MHz)	S G.Lev (dBm)	Ant(dBi)	Loss	PMea (dBm)	Limit (dBm)	Margin (dBm)	Polarity
1693.81	-33.82	9.56	9.72	-33.98	-13.00	-20.98	H
2539.43	-34.80	10.50	10.86	-35.16	-13.00	-22.16	H
3386.01	-33.42	12.78	11.57	-32.21	-13.00	-19.21	H
1693.81	-35.57	9.56	9.72	-35.73	-13.00	-22.73	V
2539.43	-34.68	10.50	10.86	-35.04	-13.00	-22.04	V
3386.01	-32.04	12.78	11.57	-30.83	-13.00	-17.83	V

LTE Band 26 / 10MHz / QPSK / RB Size 1 Offset 0/ The Worst Test Results for Middle							
Frequency(MHz)	S G.Lev (dBm)	Ant(dBi)	Loss	PMea (dBm)	Limit (dBm)	Margin (dBm)	Polarity
1638.23	-34.18	9.56	9.72	-34.34	-13.00	-21.34	H
2456.97	-35.45	10.50	10.86	-35.81	-13.00	-22.81	H
3276.09	-33.07	12.78	11.57	-31.86	-13.00	-18.86	H
1638.23	-35.38	9.56	9.72	-35.54	-13.00	-22.54	V
2456.97	-34.22	10.50	10.86	-34.58	-13.00	-21.58	V
3276.09	-32.12	12.78	11.57	-30.91	-13.00	-17.91	V



4. APPENDIX-PHOTOS OF TEST SETUP

Note: See test photos in setup photo document for the actual connections between Product and support equipment.

*****END OF THE REPORT*****